## WHAT IS CLAIMED IS:

- A threshold voltage stabilizer, for use with a MOS
   transistor having a body effect associated therewith, comprising:
- a body well located in a substrate;
- a source located in said body well; and
- a stabilization region, positioned below said body well, said
- 6 threshold voltage stabilizer being configured to provide a
- 7 stabilization voltage to said stabilization region to increase a
- 8 depletion region within said body well and thereby restrict said
- 9 body effect to stabilize a threshold voltage of said MOS
- 10 transistor.
  - 2. The threshold voltage stabilizer as recited in Claim 1
- wherein said depletion region limits an expansion of a channel
- 3 depletion region within said body well.
  - 3. The threshold voltage stabilizer as recited in Claim 1
- 2 wherein said body well is not directly connected to said source.
- 4. The threshold voltage stabilizer as recited in Claim 1
- 2 wherein said stabilization voltage is independent of a backgate
- 3 bias voltage applied to said body well.

- 5. The threshold voltage stabilizer as recited in Claim 1
  wherein said stabilization region further includes a side
  stabilization region that contacts said stabilization region.
- 6. The threshold voltage stabilizer as recited in Claim 5
  wherein said side stabilization region is adjacent said body well
  and forms a stabilization ring about said body well.
- 7. The threshold voltage stabilizer as recited in Claim 1
  wherein said body well is doped with a first dopant and said
  stabilization region is doped with a second dopant opposite to said
  first dopant.
- 8. The threshold voltage stabilizer as recited in Claim 7
  wherein a concentration of said first dopant ranges from about
  5E15/cm³ to 5E16/cm³ and a concentration of said second dopant
  ranges from about 5E18/cm³ to 2E19/cm³.
- 9. The threshold voltage stabilizer as recited in Claim 1
  wherein said stabilization voltage is provided by a variable
  voltage source configured to deliver a voltage sufficient to
  stabilize said threshold voltage.

- A method of manufacturing a threshold voltage stabilizer
   for use with a MOS transistor having a body effect associated
- 3 therewith, comprising:
- forming a body well in a substrate;
- forming a source in said body well;
- 6 creating a stabilization region wherein at least a portion of
- 7 said stabilization region is located below said body well; and
- 8 configuring said threshold voltage stabilizer to provide a
- 9 stabilization voltage to said stabilization region to increase a
- 10 depletion region within said body well and thereby restrict said
- 11 body effect to stabilize a threshold voltage of said MOS
- 12 transistor.
  - 11. The method as recited in Claim 10 wherein said
  - 2 configuring said threshold voltage stabilizer allows said depletion
- 3 region to limit an expansion of a channel depletion region within
- 4 said body well.
  - 12. The method as recited in Claim 10 wherein forming said
- 2 body well allows electrical isolation from said source.
- 13. The method as recited in Claim 10 wherein said creating
- 2 a stabilization region further includes creating a side
- 3 stabilization region that contacts said stabilization region.

- 14. The method as recited in Claim 13 wherein said side 2 stabilization region is adjacent said body well and forms a 3 stabilization ring about said body well.
- 15. The method as recited in Claim 10 wherein said forming said body well includes doping said body well with a first dopant and said forming said stabilization region includes doping said stabilization region with a second dopant opposite to said first dopant.
- 16. The method as recited in Claim 15 wherein a concentration

  of said first dopant ranges from about 5E15/cm³ to 5E16/cm³ and a

  concentration of said second dopant ranges from about 5E18/cm³ to

  2E19/cm³.
- 17. The method as recited in Claim 10 further including providing said stabilization voltage from a variable voltage source that delivers a voltage sufficient to stabilize said threshold voltage.

- 18. An integrated circuit, comprising:
- memory cells located on a semiconductor substrate;
- MOS transistors located on said semiconductor substrate, said
- 4 transistors having a body effect associated therewith;
- 5 threshold voltage stabilizers, for use with said transistors,
- 6 located on said semiconductor substrate wherein each includes:
- 7 a body well located in said semiconductor substrate;
- a source located in said body well; and
- a stabilization region, positioned below said body well,
- said threshold voltage stabilizer providing a stabilization voltage
- 11 to said stabilization region to increase a depletion region within
- 12 said body well and thereby restrict said body effect to stabilize
- a threshold voltage of said MOS transistor; and
- interconnects interconnecting said memory cells, said MOS
- 15 transistors and said threshold voltage stabilizers to form an
- operative integrated circuit.
  - 19. The integrated circuit as recited in Claim 18 wherein
  - 2 said depletion region limits an expansion of a channel depletion
- 3 region within said body well.
- 20. The integrated circuit as recited in Claim 18 wherein
- 2 said body well is not directly connected to said source.

- 21. The integrated circuit as recited in Claim 18 wherein said stabilization voltage is substantially independent of a backgate bias voltage applied to said body well.
- 22. The integrated circuit as recited in Claim 18 wherein said stabilization region further includes a side stabilization region that contacts said stabilization region.
- 23. The integrated circuit as recited in Claim 22 wherein said side stabilization region is adjacent said body well and forms a stabilization ring about said body well.
- 24. The integrated circuit as recited in Claim 18 wherein said stabilization voltage is provided by a variable voltage source that delivers a voltage sufficient to stabilize said threshold voltage.
- 25. The integrated circuit as recited in Claim 18 wherein said threshold voltage stabilizers form a portion of said memory cells.